



# N-Channel 25-V (D-S) MOSFET

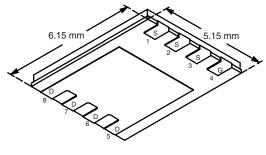
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
25	0.0046 at V <sub>GS</sub> = 10 V	40	13 nC		
	0.0062 at V <sub>GS</sub> = 4.5 V	40	13110		

# **FEATURES**

- Halogen-free
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

# COMPLIANT

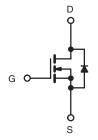
#### PowerPAK SO-8



Ordering Information: SiR436DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

# **APPLICATIONS**

- Low-Side Switch
- Server, VRM



N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	25	V	
Gate-Source Voltage		$V_{GS}$	± 20		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 70 ^{\circ}\text{C}$ $T_{A} = 25 ^{\circ}\text{C}$ $T_{A} = 70 ^{\circ}\text{C}$	I <sub>D</sub>	40 <sup>a</sup> 40 <sup>a</sup> 25 <sup>b, c</sup> 20 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	80		
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	40		
Avalanche Energy	L = 0.111111	E <sub>AS</sub>	80	mJ	
Continuous Source-Drain Diode Current $ T_C = 25 \text{ °C} $ $ T_A = 25 \text{ °C} $		I <sub>S</sub>	40 <sup>a</sup> 4.1 <sup>b, c</sup>	Α	
Maximum Power Dissipation		P <sub>D</sub>	50 32 5 <sup>b, c</sup> 3.2 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s R <sub>thJA</sub> 20 25		°C/W			
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	2.0	2.5	- 0///	

- a. Based on  $T_C$  = 25 °C. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 70 °C/W.

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SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	T			ı	ı	1	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	l <sub>D</sub> = 250 μA		24		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 5.5		111 07 0	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V			1	μΑ	
Zoro date voltage Diam current		$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			5	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	50			Α	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0038	0.0046	Ω	
Diain-Source On-State Resistance	' 'DS(on)	$V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$		0.005	0.0062		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		60		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			1715		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		425			
Reverse Transfer Capacitance	C <sub>rss</sub>			170			
Total Oaks Observes	0	$V_{DS} = 12.5 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		31	47	nC	
Total Gate Charge	Q <sub>g</sub>			13	20		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 12.5 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		4.5			
Gate-Drain Charge	$Q_{gd}$			3.9			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.0	2.0	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			22	40		
Rise Time	t <sub>r</sub>	$V_{DD} = 12.5 \text{ V}, R_L = 12.5 \Omega$		11	25	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1.0 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		32	50		
Fall Time	t <sub>f</sub>			8	25		
Turn-On Delay Time	t <sub>d(on)</sub>			13	25	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 12.5 \text{ V}, R_1 = 12.5 \Omega$		8	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1.0 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		30	40		
Fall Time	t <sub>f</sub>	· ·		9	15		
Drain-Source Body Diode Characteristi	cs ·			I.			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			40		
Pulse Diode Forward Current	I <sub>SM</sub>				80	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 4.1 A, V <sub>GS</sub> = 0 V		0.75	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			28	56	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			20	40	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 4.1 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		15			
Reverse Recovery Rise Time	t <sub>b</sub>			13		ns	

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

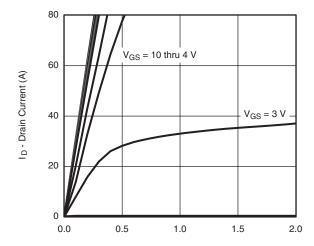
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





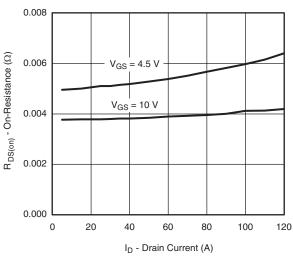


# TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

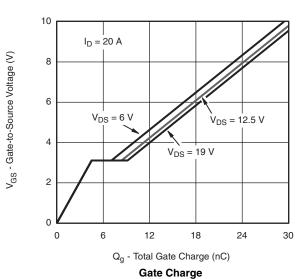


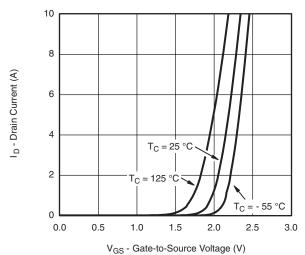
 $V_{\text{DS}}$  - Drain-to-Source Voltage (V)

### **Output Characteristics**

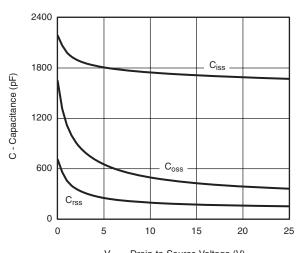


On-Resistance vs. Drain Current and Gate Voltage



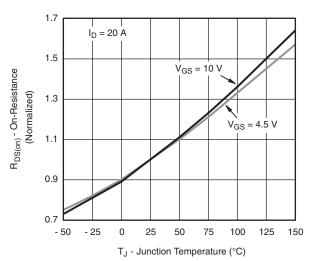


Transfer Characteristics



V<sub>DS</sub> - Drain-to-Source Voltage (V)

### Capacitance

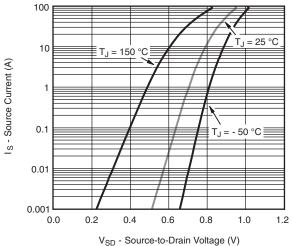


On-Resistance vs. Junction Temperature

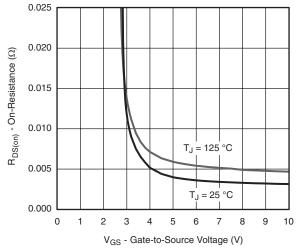
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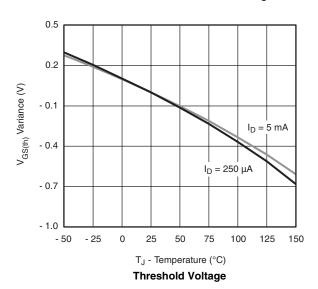
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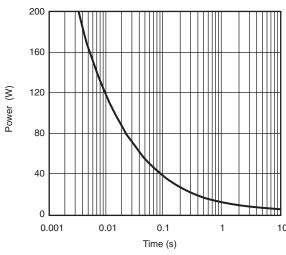


Source-Drain Diode Forward Voltage

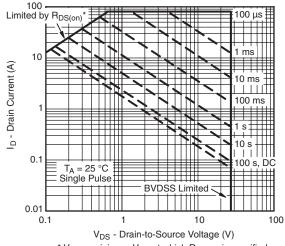


On-Resistance vs. Gate-to-Source Voltage





Single Pulse Power (Junction-to-Ambient)

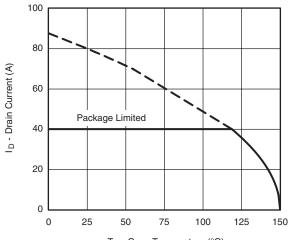


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

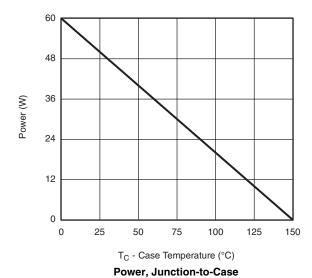


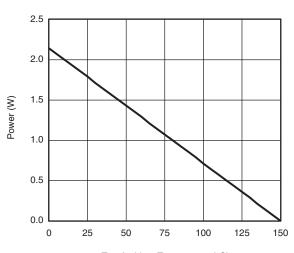
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T<sub>C</sub> - Case Temperature (°C)

## **Current Derating\***





T<sub>A</sub> - Ambient Temperature (°C)

Power, Junction-to-Ambient

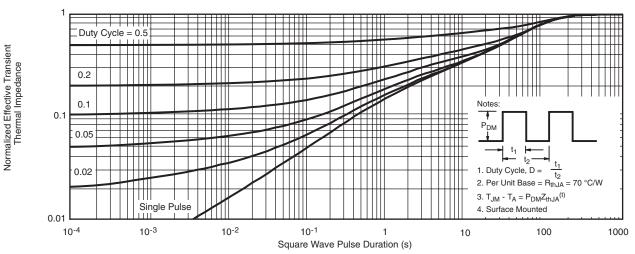
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

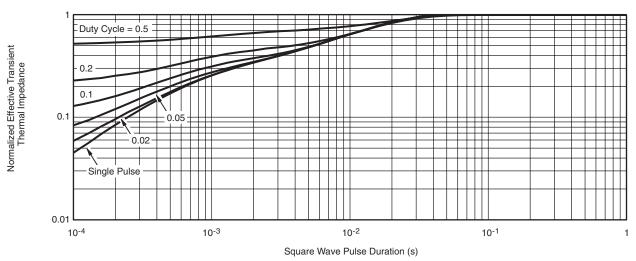
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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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